UFS Series N-Channel IGBT with Anti-Parallel Hyperfast Diode

40 A, 600 V

HGTG20N60B3D

The HGTG20N60B3D is a MOS gated high voltage switching device combining the best features of MOSFETs and bipolar transistors. The device has the high input impedance of a MOSFET and the low on−state conduction loss of a bipolar transistor. The much lower on−state voltage drop varies only moderately between 25°C and 150°C. The diode used in anti−parallel with the IGBT is the RHRP3060.

The IGBT is ideal for many high voltage switching applications operating at moderate frequencies where low conduction losses are essential.

Formerly developmental type TA49016.

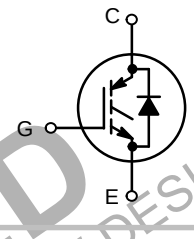
Features

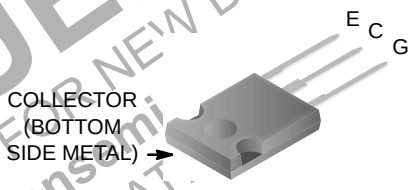
- 40 A, 600 V at T_C = 25°C
- Typical Fall Time 140 ns at 150°C
- Short Circuit Rated
- Low Conduction Loss
- Hyperfast Anti−Parallel Diode
- This is a Pb−Free Device

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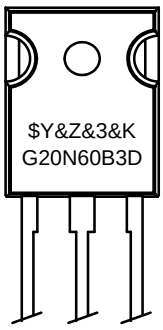
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TO−247−3LD SHORT LEAD
CASE 340CK
JEDEC STYLE

MARKING DIAGRAM



$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
G20N60B3D	= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

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ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise specified)

Parameter	Symbol	HGTG20N60B3D	Unit
Collector to Emitter Voltage	BV_{CES}	600	V
Collector to Gate Voltage, R_{GE} = 1 MΩ	BV_{CGR}	600	V
Collector Current Continuous At T_C = 25°C At T_C = 110°C	 I_{C25} I_{C110}	 40 20	 A A
Average Diode Forward Current at 110°C	$I_{(AVG)}$	20	A
Collector Current Pulsed (Note 1)	I_{CM}	160	A
Gate to Emitter Voltage Continuous	V_{GES}	±20	V
Gate to Emitter Voltage Pulsed	V_{GEM}	±30	V
Switching Safe Operating Area at T_C = 150°C	SSOA	30 A at 600 V	
Power Dissipation Total at T_C = 25°C	P_D	165	W
Power Dissipation Derating T_C > 25°C		1.32	W/°C
Operating and Storage Junction Temperature Range	T_J, T_{STG}	−40 to 150	°C
Maximum Lead Temperature for Soldering	T_L	260	°C
Short Circuit Withstand Time (Note 2) at V_{GE} = 15 V	t_{SC}	4	μs
Short Circuit Withstand Time (Note 2) at V_{GE} = 10 V	t_{SC}	10	μs

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. V_{CE} = 360 V, T_C =125°C, R_G = 25 Ω

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
Collector to Emitter Breakdown Voltage	BV_{CES}	I_C = 250 μA, V_{GE} = 0 V		600	–	–	V
Collector to Emitter Leakage Current	I_{CES}	V_{CE} = BV_{CES}	T_C = 25°C	–	–	250	μA
			T_C = 150°C	–	–	2.0	mA
Collector to Emitter Saturation Voltage	$V_{CE(SAT)}$	I_C = I_{C110}, V_{GE} = 15 V	T_C = 25°C	–	1.8	2.0	V
			T_C = 150°C	–	2.1	2.5	V
Gate to Emitter Threshold Voltage	$V_{GE(TH)}$	I_C = 250 μA, V_{CE} = V_{GE}		3.0	5.0	6.0	V
Gate to Emitter Leakage Current	I_{GES}	V_{GE} = ±20 V		–	–	±100	nA
Switching SOA	SSOA	T_C = 150°C, V_{GE} = 15 V, R_G = 10 Ω, L = 45 μH	V_{CE} = 480 V	100	–	–	A
			V_{CE} = 600 V	30	–	–	A
Gate to Emitter Plateau Voltage	V_{GEP}	I_C = I_{C110}, V_{CE} = 0.5 BV_{CES}		–	8.0	–	V
On−State Gate Charge	$Q_{G(ON)}$	I_C = I_{C110}, V_{CE} = 0.5 BV_{CES}	V_{GE} = 15 V	–	80	105	nC
			V_{GE} = 20 V	–	105	135	nC
Current Turn−On Delay Time	$t_{d(ON)I}$	T_C = 150°C, I_{CE} = I_{C110}, V_{CE} = 0.8 BV_{CES}, V_{GE} = 15 V, R_G = 10 Ω, L = 100 μH		–	25	–	ns
Current Rise Time	t_{rI}			–	20	–	ns
Current Turn−Off Delay Time	$t_{d(OFF)I}$			–	220	275	ns
Current Fall Time	t_{fI}			–	140	175	ns
Turn−On Energy	E_{ON}			–	475	–	μJ
Turn−Off Energy (Note 3)	E_{OFF}			–	1050	–	μJ
Diode Forward Voltage	V_{EC}	I_{EC} = 20 A		–	1.5	1.9	V
Diode Reverse Recovery Time	t_{rr}	I_{EC} = 20 A, dI_{EC}/dt = 100 A/μs		–	–	55	ns
		I_{EC} = 1 A, dI_{EC}/dt = 100 A/μs		–	–	45	ns

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ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Thermal Resistance	$R_{\theta JC}$	IGBT	−	−	0.76	°C/W
		Diode	−	−	1.2	°C/W

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Turn−Off Energy Loss (E_{OFF}) is defined as the integral of the instantaneous power loss starting at the trailing edge of the input pulse and ending at the point where the collector current equals zero (I_{CE} = 0 A) The HGTG20N60B3D was tested per JEDEC standard No. 24−1 Method for Measurement of Power Device Turn−Off Switching Loss. This test method produces the true total Turn−Off Energy Loss. Turn−On losses include diode losses.

TYPICAL PERFORMANCE CURVES

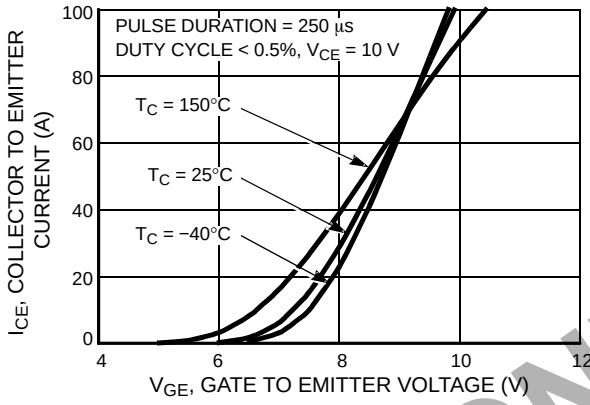


Figure 1. TRANSFER CHARACTERISTICS

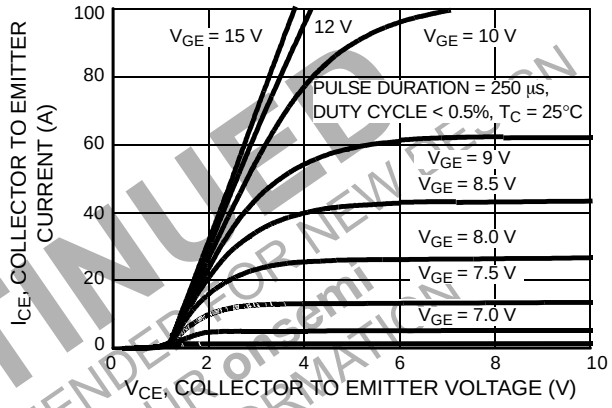


Figure 2. SATURATION CHARACTERISTICS

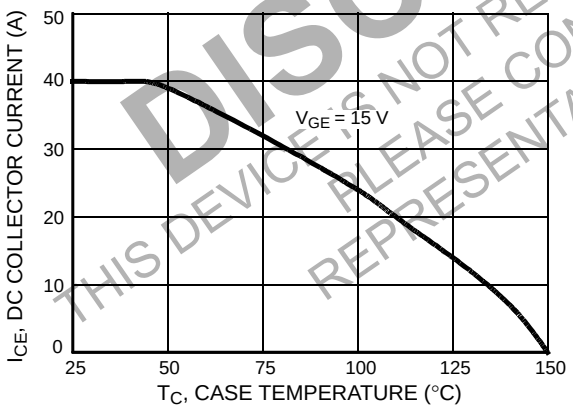


Figure 3. DC COLLECTOR CURRENT vs. CASE TEMPERATURE

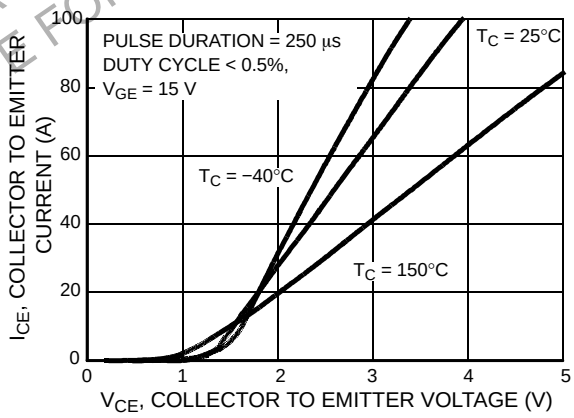


Figure 4. COLLECTOR TO EMITTER ON−STATE VOLTAGE

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TYPICAL PERFORMANCE CURVES (continued)

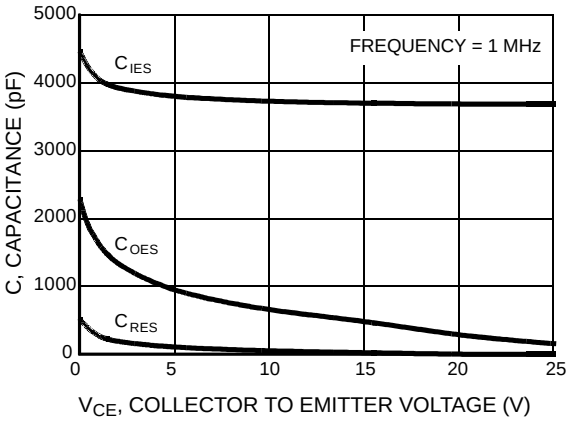


Figure 5. CAPACITANCE vs. COLLECTOR TO EMITTER VOLTAGE

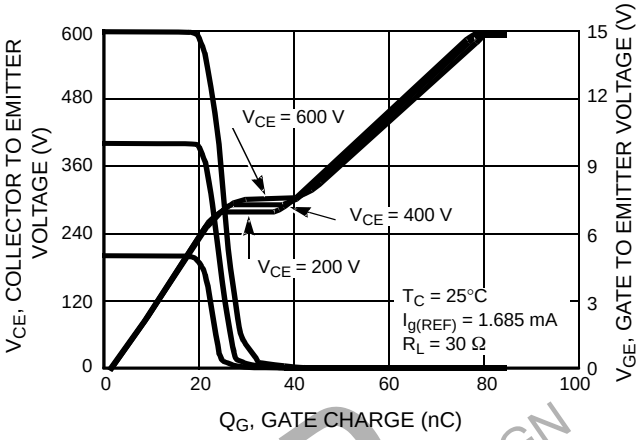


Figure 6. GATE CHARGE WAVEFORMS

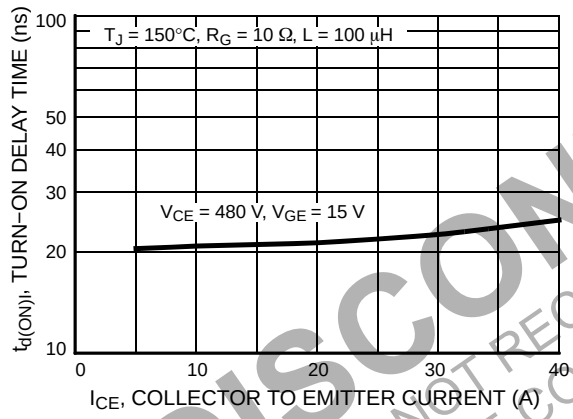


Figure 7. TURN−ON DELAY TIME vs. COLLECTOR TO EMITTER CURRENT

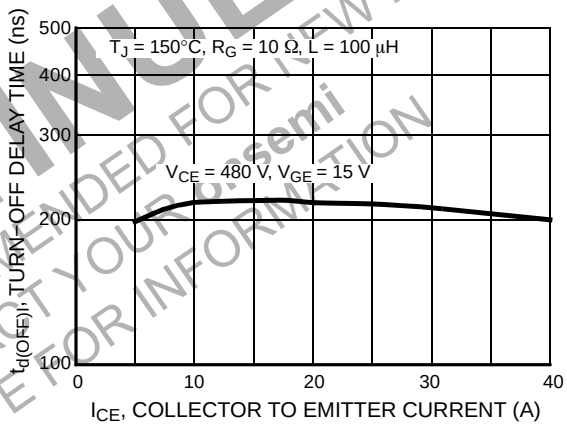


Figure 8. TURN−OFF DELAY TIME vs. COLLECTOR TO EMITTER CURRENT

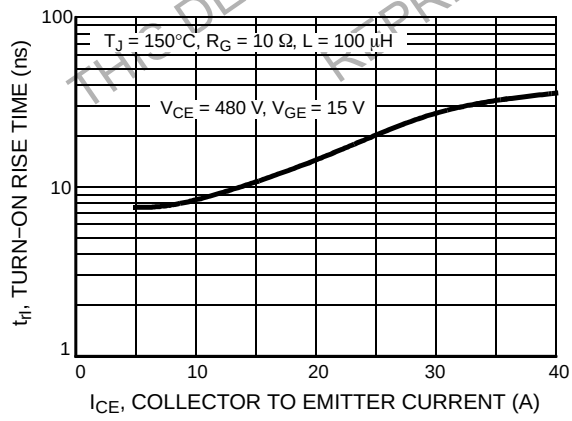


Figure 9. TURN−ON RISE TIME vs. COLLECTOR TO EMITTER CURRENT

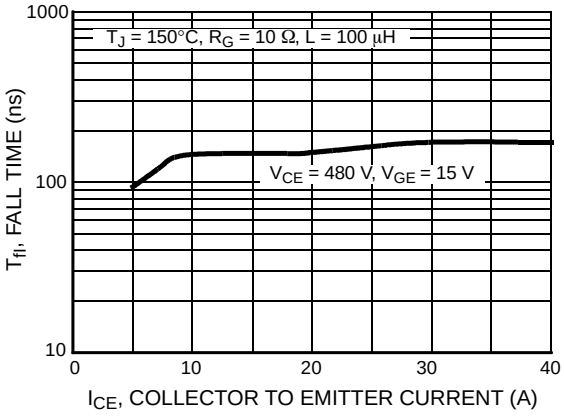


Figure 10. TURN−OFF FALL TIME vs. COLLECTOR TO EMITTER CURRENT

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TYPICAL PERFORMANCE CURVES (continued)

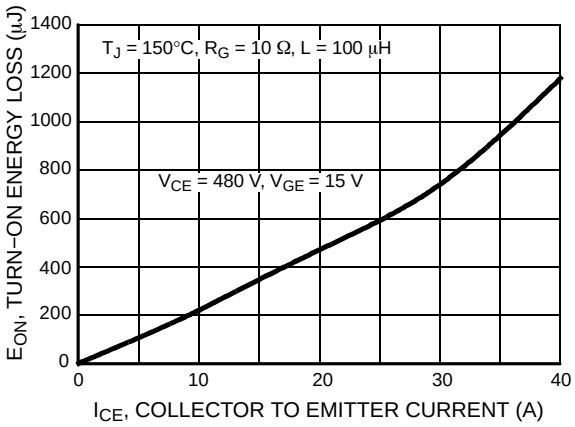


Figure 11. TURN−ON ENERGY LOSS vs. COLLECTOR TO EMITTER CURRENT

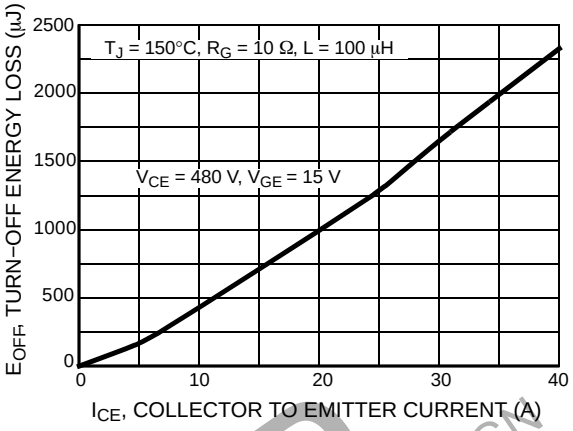


Figure 12. TURN−OFF ENERGY LOSS vs. COLLECTOR TO EMITTER CURRENT

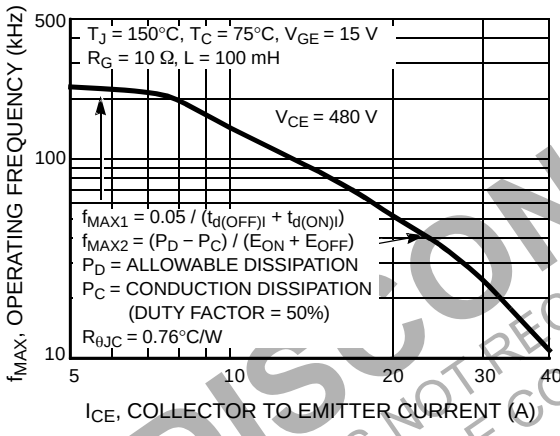


Figure 13. OPERATING FREQUENCY vs. COLLECTOR TO EMITTER CURRENT

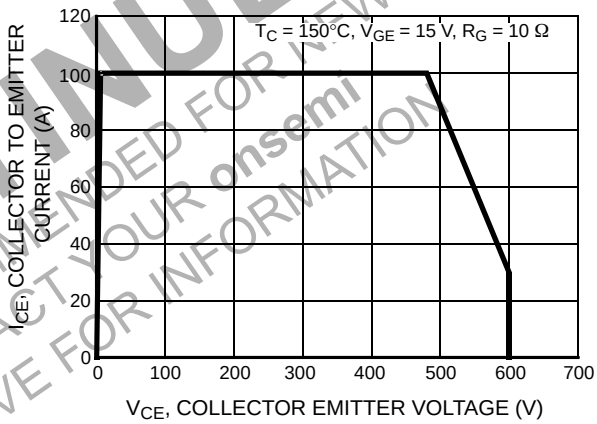


Figure 14. SWITCHING SAFE OPERATING AREA

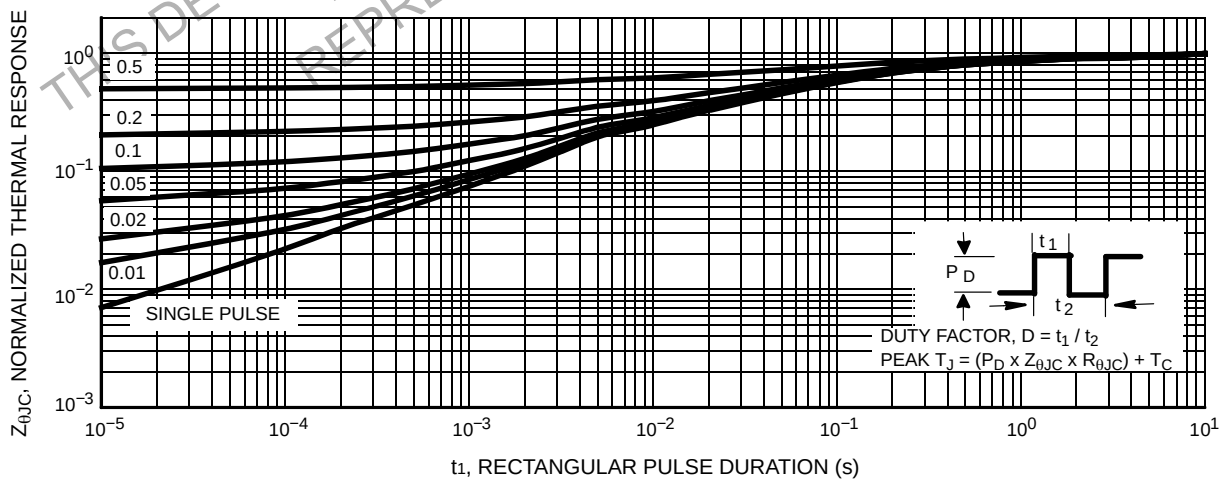


Figure 15. IGBT NORMALIZED TRANSIENT THERMAL RESPONSE, JUNCTION TO CASE

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TYPICAL PERFORMANCE CURVES (continued)

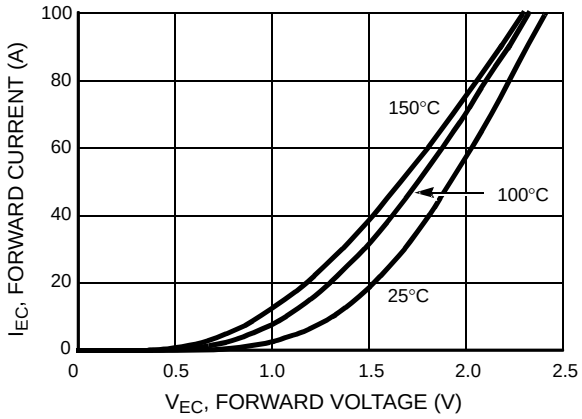


Figure 16. DIODE FORWARD CURRENT vs. FORWARD VOLTAGE DROP

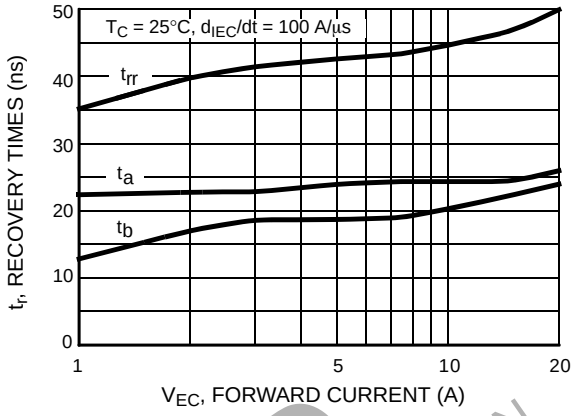


Figure 17. RECOVERY TIMES vs. FORWARD CURRENT

TEST CIRCUIT AND WAVEFORMS

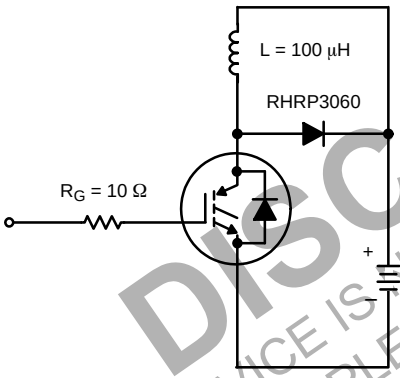


Figure 18. INDUCTIVE SWITCHING TEST CIRCUIT

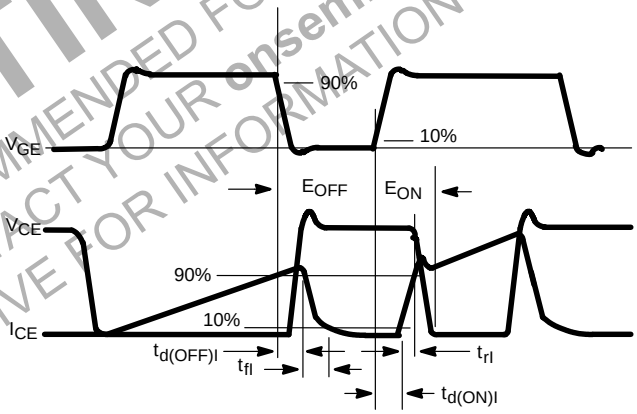


Figure 19. SWITCHING TEST WAVEFORMS

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HANDLING PRECAUTIONS FOR IGBTs

Insulated Gate Bipolar Transistors are susceptible to gate−insulation damage by the electrostatic discharge of

energy through the devices. When handling these devices, care should be exercised to assure that the static charge built in the handler's body capacitance is not discharged through the device. With proper handling and discharge procedures, however, IGBTs are currently being extensively used in production by numerous equipment manufacturers in military, industrial and consumer applications, with virtually no damage problems due to electrostatic discharge. IGBTs can be handled safely if the following basic precautions are taken:

1. Prior to assembly into a circuit, all leads should be kept shorted together either by the use of metal shorting springs or by the insertion into conductive material such as "ECCOSORBD™ LD26" or equivalent.
2. When devices are removed by hand from their carriers, the hand being used should be grounded by any suitable means − for example, with a metallic wristband.
3. Tips of soldering irons should be grounded.
4. 1. Devices should never be inserted into or removed from circuits with power on.
5. *Gate Voltage Rating* − Never exceed the gate−voltage rating of V_{GEM}. Exceeding the rated V_{GE} can result in permanent damage to the oxide layer in the gate region.
6. *Gate Termination* − The gates of these devices are essentially capacitors. Circuits that leave the gate open− circuited or floating should be avoided. These conditions can result in turn−on of the device due to voltage buildup on the input capacitor due to leakage currents or pickup.
7. *Gate Protection* - These devices do not have an internal monolithic zener diode from gate to emitter. If gate protection is required an external zener is recommended.

OPERATING FREQUENCY INFORMATION

Operating frequency information for a typical device (Figure 13) is presented as a guide for estimating device performance for a specific application. Other typical frequency vs collector current (I_{CE}) plots are possible using the information shown for a typical unit in Figures 4, 7, 8, 11 and 12. The operating frequency plot (Figure 13) of a typical device shows f_{MAX1} or f_{MAX2} whichever is smaller at each point. The information is based on measurements of a typical device and is bounded by the maximum rated junction temperature.

f_{MAX1} is defined by $f_{MAX1} = 0.05 / (t_{d(OFF)I} t_{d(ON)I})$. Deadtime (the denominator) has been arbitrarily held to 10% of the on− state time for a 50% duty factor. Other definitions are possible. $t_{d(OFF)I}$ and $t_{d(ON)I}$ are defined in Figure 19.

Device turn−off delay can establish an additional frequency limiting condition for an application other than T_{JM}. $t_{d(OFF)I}$ is important when controlling output ripple under a lightly loaded condition.

f_{MAX2} is defined by $f_{MAX2} = (P_D - P_C) / (E_{OFF} + E_{ON})$. The allowable dissipation (P_D) is defined by $P_D = (T_{JM} - T_C) / R_{\theta JC}$. The sum of device switching and conduction losses must not exceed P_D. A 50% duty factor was used (Figure 13) and the conduction losses (P_C) are approximated by $P_C = (V_{CE} \times I_{CE}) / 2$.

E_{ON} and E_{OFF} are defined in the switching waveforms shown in Figure 19. E_{ON} is the integral of the instantaneous power loss ($I_{CE} \times V_{CE}$) during turn−on and E_{OFF} is the integral of the instantaneous power loss during turn−off. All tail losses are included in the calculation for E_{OFF}; i.e. the collector current equals zero ($I_{CE} = 0$).

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ORDERING INFORMATION

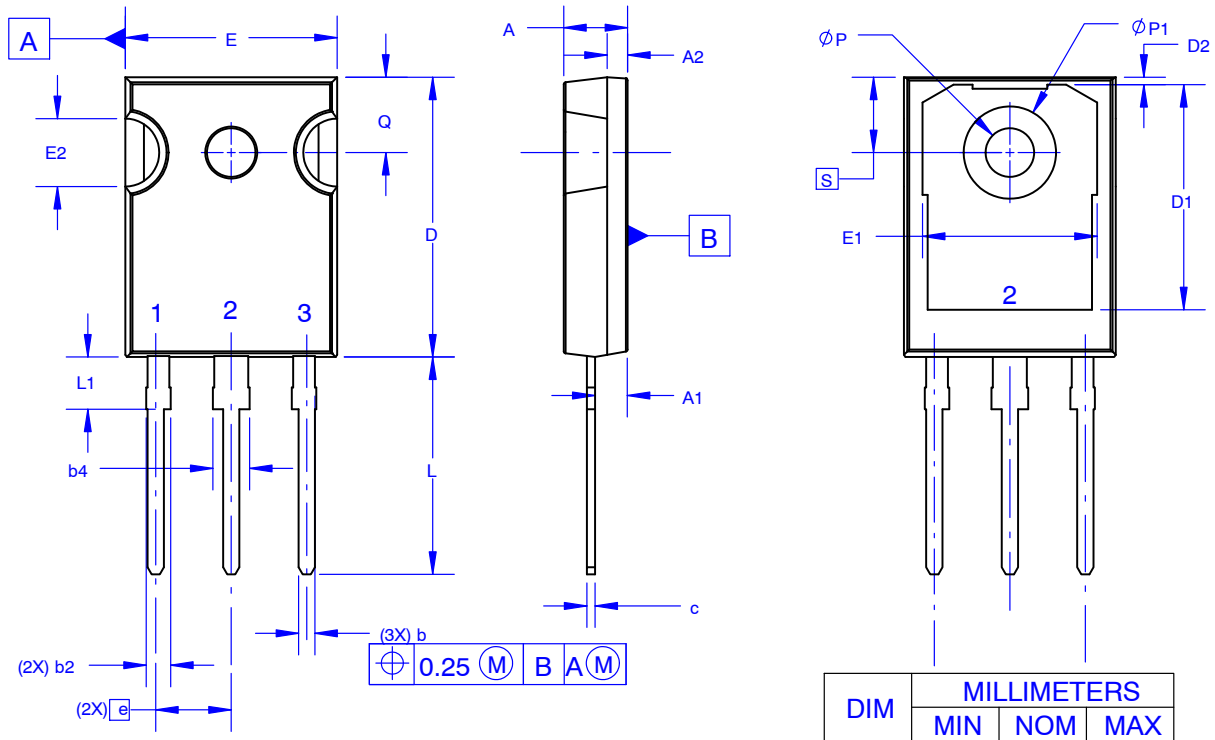
Part Number	Package	Brand	Shipping
HGTG20N60B3D	TO−247	G20N60B3D	450 Units / Tube

NOTE: When ordering, use the entire part number.

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TO−247−3LD SHORT LEAD
CASE 340CK
ISSUE A

DATE 31 JAN 2019

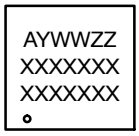


DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.58	4.70	4.82
A1	2.20	2.40	2.60
A2	1.40	1.50	1.60
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
c	0.51	0.61	0.71
D	20.32	20.57	20.82
D1	13.08	~	~
D2	0.51	0.93	1.35
E	15.37	15.62	15.87
E1	12.81	~	~
E2	4.96	5.08	5.20
e	~	5.56	~
L	15.75	16.00	16.25
L1	3.69	3.81	3.93
ØP	3.51	3.58	3.65
ØP1	6.60	6.80	7.00
Q	5.34	5.46	5.58
S	5.34	5.46	5.58

NOTES: UNLESS OTHERWISE SPECIFIED.

A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	**TO−247−3LD SHORT LEAD**	**PAGE 1 OF 1**

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Elektronik komponent tedarikinde Entegreci

Entegreci, Eskişehir merkezli, Türkiye geneline satış yapan bir elektronik komponent mağazasıdır. Entegreler (IC), mikrodenetleyiciler, transistörler, diyotlar, pasif elemanlar, konnektörler, modüller ve geliştirme kartları tek adetten seri üretim adetlerine kadar satılır. Ürün sayfalarında güncel stok durumunu, fiyatı ve datasheet bağlantısını bulabilirsiniz.

Parça koduyla arama

Üretici parça numarasını yazın; stok ve fiyatı hemen görün.

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Ürün kategorileri

Entegreden kapasitöre tüm elektronik komponent kategorileri.

Kategorilere göz atın

Üreticiler

Aradığınız üreticinin ürünlerini tek sayfada inceleyin.

Üreticileri görün

Toplu alım ve teklif

Listede olmayan ya da yüksek adetli parçalar için teklif isteyin.

Teklif isteyin

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Entegreci is an online electronic components store based in Türkiye. Search by manufacturer part number to see stock, prices and datasheets for integrated circuits, microcontrollers, transistors, passive components and connectors, or request a quote for parts that are not listed.

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